


<b>Search Notes</b>  	<b>Application/Control No.</b>  10799231	<b>Applicant(s)/Patent Under Reexamination</b>  YEH ET AL.
	<b>Examiner</b>  M. MUJTABA K CHAUDRY	<b>Art Unit</b>  2112

SEARCHED			
Class	Subclass	Date	Examiner
714	758	4/2/2008	MC
714	780	4/2/2008	MC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST DATABASE (UPDATED)	4/2/2008	MC
USPATS	4/2/2008	MC
USPGPUBS	4/2/2008	MC
EPO	4/2/2008	MC
JPO	4/2/2008	MC
DERWANT	4/2/2008	MC
IBM-TDB	4/2/2008	MC
GOOGLE	4/2/2008	MC
IEEE	4/2/2008	MC
DOUBLE PATENTING 10799232	4/2/2008	MC

INTERFERENCE SEARCH			
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INTERFERE NCE SEARCH (PGPUBS)		4/2/2008	MC